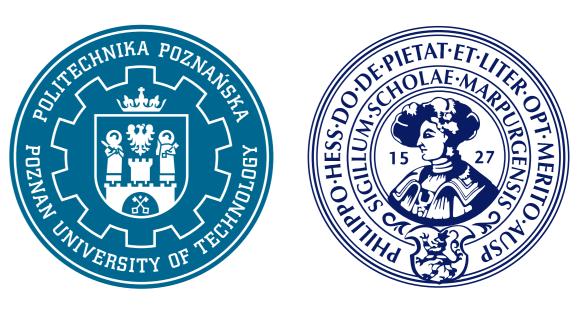
# OPTIMIZING THE F-MEASURE IN MULTI-LABEL CLASSIFICATION: Plug-in Rule Approach versus Structured Loss Minimization

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## Multi-Label Classification (MLC)

- For a feature vector x predict a binary vector of responses y using a prediction function h(x):

$$\boldsymbol{x} = (x_1, x_2, \dots, x_p) \xrightarrow{\boldsymbol{h}(\boldsymbol{x})} \boldsymbol{y} = (y_1, y_2, \dots, y_m)$$

- Main challenges in multi-label classification:
- Appropriate modeling of label dependencies between labels

$$y_1, y_2, \ldots, y_m$$

• A multitude of multivariate loss functions defined over the binary vectors

 $\ell(oldsymbol{y},oldsymbol{h}(oldsymbol{x}))$ 

## $F_{\beta}$ -measure

– We focus on the  $F_{\beta}$ -measure-based loss function ( $F_{\beta}$ -loss):

$$\ell_{F_{\beta}}(\boldsymbol{y}, \boldsymbol{h}(\boldsymbol{x})) = 1 - F_{\beta}(\boldsymbol{y}, \boldsymbol{h}(\boldsymbol{x}))$$

$$= 1 - \frac{(1 + \beta^2) \sum_{i=1}^{m} y_i h_i(\boldsymbol{x})}{\beta^2 \sum_{i=1}^{m} y_i + \sum_{i=1}^{m} h_i(\boldsymbol{x})} \in [0, 1].$$

- Provides a **better balance** between relevant and irrelevant labels.
- However, it **is not easy** to optimize.

# Two Approaches

# Plug-in rule approach Structured loss minimization training examples minimization **LEARNING** of *F*-based loss function Scoring Function

# training examples **LEARNING** Probabilistic Model Inference minimization query $x \rightarrow$ $\rightarrow$ result $\hat{y}$ of *F*-based loss function

#### Structured Loss Minimization with SSVM

- Use a scoring function f(y, x)
- Minimize the **structured hinge loss** [5]:

Inference  $\rightarrow$  result  $\hat{y}$ 

$$\tilde{\ell}_h(\boldsymbol{y}, \boldsymbol{x}, f) = \max_{\boldsymbol{y}' \in \mathcal{Y}} \{ \ell_F(\boldsymbol{y}, \boldsymbol{y}') + f(\boldsymbol{y}', \boldsymbol{x}) \} - f(\boldsymbol{y}, \boldsymbol{x}),$$

- With  $\ell_F(y, y')$  used for margin rescaling.
- Predict according to:

$$m{h}(m{x}) = \underset{m{y} \in \mathcal{Y}}{\operatorname{arg\,max}} f(m{y}, m{x}).$$

- Requires solving the arg max and constraint generation problem.
- Two algorithms:

#### **RML** [3]

No label interactions:

$$f(oldsymbol{y},oldsymbol{x}) = \sum_{i=1}^m f_i(y_i,oldsymbol{x})$$

Quadratic learning and linear prediction

### **SML** [4]

Submodular interactions:

$$f(oldsymbol{y},oldsymbol{x}) = \sum_{i=1}^m f_i(y_i,oldsymbol{x}) + \sum_{y_k,y_l} f_{k,l}(y_k,y_l)$$

More complex (graph-cut and approximate algorithms)

# Plug-in Rule Approaches with LR

- Plug estimates of required parameters into the **Bayes classifier**.
- The brute-force algorithm is **intractable**:

$$\boldsymbol{h}^* = \arg\min_{\boldsymbol{h} \in \mathcal{Y}} \mathbb{E}\left[\ell_{F_{\beta}}(\boldsymbol{Y}, \boldsymbol{h})\right] = \arg\max_{\boldsymbol{h} \in \mathcal{Y}} \sum_{\boldsymbol{v} \in \mathcal{V}} \Pr(\boldsymbol{y}) \frac{(\beta + 1) \sum_{i=1}^{m} y_i h_i}{\beta^2 \sum_{i=1}^{m} y_i + \sum_{i=1}^{m} h_i}$$

- Approximation needed? Not really. The exact solution is tractable!

- Assumes label independence
   No assumptions
- Linear number of parameters:  $\Pr(y_i = 1)$
- Inference based on dynamic programming [6]
- Reduction to LR for each label

- Quadratic number of parameters:  $\Pr(y_i = 1, s = \sum_i y_i)$
- o Inference based on matrix multiplication and top k selection [1]
- o Reduction to multinomial LR for each label

# Theoretical Analysis

- Computational complexity (with respect to the number of labels):

	RML SML	LFP EFP
learning	$\mathcal{O}(m^2)$ $\mathcal{O}(m^4)$	$\mathcal{O}(m)$ $\mathcal{O}(m^2)$
prediction	$\mathcal{O}(m)$ $\mathcal{O}(m^3)$	$\mathcal{O}(m^2)$ $\mathcal{O}(m^3)$

- Statistical consistency of multi-label classifiers [2]:
  - RML and SML are **not consistent**
  - EFP is **consistent**.

# **Empirical Evaluation On Benchmark Datasets**

	HL[%]↓	<i>F</i> [%]↑	$t_{cv}$	$t_{train}$	$t_{inf}$	HL[%]↓	<i>F</i> [%]↑	$t_{cv}$	$t_{train}$	$t_{inf}$
	IMAGE					SCENE				
BR	19.90	43.63	9	0.392	0.087	10.51	55.73	29	0.733	0.241
LFP	27.55	58.86	9	0.392	0.119	12.18	74.38	29	0.733	0.270
EFP	26.07	59.77	24	0.606	0.183	12.22	74.44	72	0.995	0.399
RML	25.07	57.49	94	1.104	0.051	9.70	73.92	73	1.001	0.118
SML	28.82	56.99	156	7.116	0.052	15.65	68.50	52	1.129	0.123
	YEAST		Medical							
BR	20.03	60.59	12	0.429	0.128	1.17	70.19	9	1	0.952
LFP	22.24	65.02	12	0.429	0.146	1.18	81.27	9	1	1.513
EFP	22.82	65.47	101	2.004	0.367	1.23	80.39	16	1	1.883
RML	22.82	64.78	206	5.194	0.056	1.20	80.63	1253	30	0.144
SML	24.52	63.96	319	4.385	0.070	2.50	67.90	715	23	0.773
	Enron		Mediamill							
BR	4.54	55.49	52	4	1.016	3.19	51.21	3238	118	13
LFP	6.09	56.86	52	4	1.519	3.67	55.15	3238	118	20
EFP	5.34	61.04	214	6	2.628	3.63	55.16	24620	440	30
RML	6.35	57.69	3897	41	0.143	4.12	49.35	_	1125	7
SML	7.82	54.61	18780	62	0.887	4.18	50.02	_	10365	131

Experimental results for Hamming loss (HL),  $F_1$ , and running times (in seconds) of cross-validation ( $t_{cv}$ ), training  $(t_{train})$  (for the best set of parameters) and inference  $(t_{inf})$ . The best results are marked by a '\*'. BR denotes Binary Relevance which is a baseline in the comparison.

## References

- [1] K. Dembczyński, W. Waegeman, W. Cheng, and E. Hüllermeier. An exact algorithm for F-measure maximization. In NIPS, volume 25, 2011.
- [2] W. Gao and Z.-H. Zhou. On the consistency of multi-label learning. Journal of Machine Learning Research -Proceedings Track, 19:341-358, 2011.
- [3] J. Petterson and T. S. Caetano. Reverse multi-label learning. In Advances in Neural Information Processing Systems 24, pages 1912–1920, 2010.
- [4] J. Petterson and T. S. Caetano. Submodular multi-label learning. In Advances in Neural Information Processing Systems 24, pages 1512–1520, 2011.

[5] Y. Tsochantaridis, T. Joachims, T. Hofmann, and Y. Altun. Large margin methods for structured and

- interdependent output variables. JMLR, 6:1453-1484, 2005.
- [6] N. Ye, K. Chai, W. Lee, and H. Chieu. Optimizing F-measures: a tale of two approaches. In ICML, 2012.







